

High-Performance 8-Bit CMOS Microcontroller

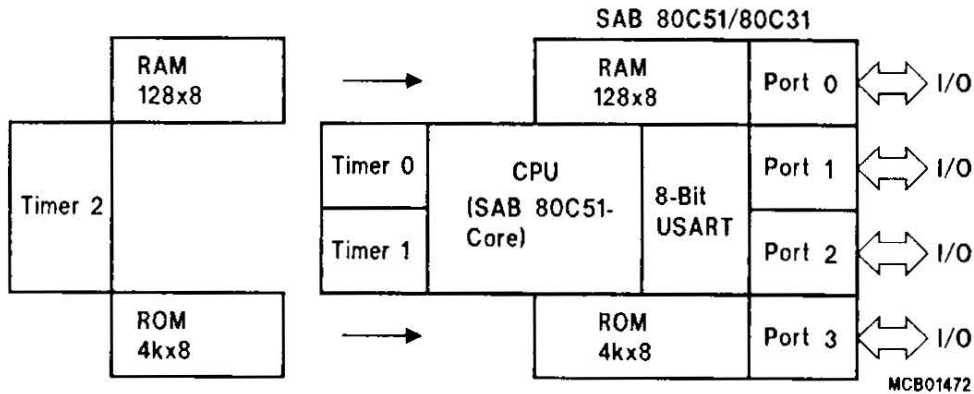
SAB 80C52/80C32

Preliminary

SAB 80C52
SAB 80C32

CMOS microcontroller with factory-maskprogrammable ROM
CMOS microcontroller for external ROM

- Versions for 12 MHz /16MHz /20 MHz operating frequency
- 8 K × 8 ROM (SAB 80C52 only)
- 256 × 8 RAM
- Four 8-bit ports, 32 I/O lines
- Three 16-bit timer/event counters
- High-performance full-duplex serial channel with flexible transmit/receive baud rate capability
- External memory expandable up to 128 Kbytes
- Boolean processor
- Most instructions execute in 1 μs /750 ns /666 ns
- Multiply and divide in 4 μs /3 μs /2.7 μs
- Six interrupt sources, two priority levels
- Idle and power-down operation
- Fully functionally compatible with SAB 8052A/8032A
- Three temperature ranges available:
 - 0 to 70°C,
 - 40 to +85°C,
 - 40 to +110°C
- P-DIP-40 and P-LCC-44 package



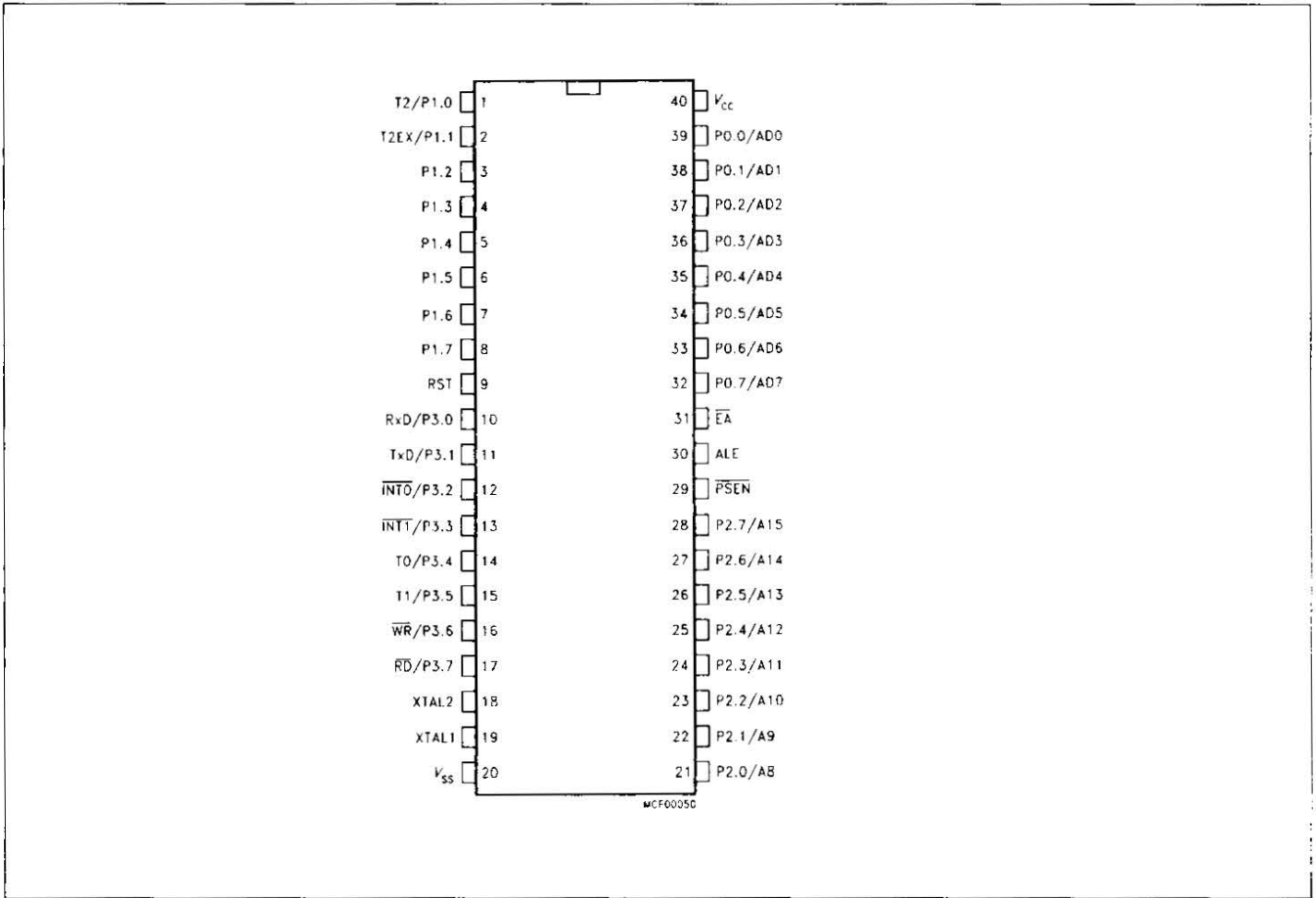
The SAB 80C52/80C32 is a standalone, high-performance CMOS single-chip microcontroller, designed in Siemens ACMOS technology. It is functionally compatible with the SAB 8052A/8032A devices in MYMOS technology.

Furthermore, it is backwardly compatible with the SAB 80C51/80C31. The low-power properties of ACMOS technology allow applications where power consumption and dissipation are critical. In addition, the SAB 80C52/80C32 has two software-selectable modes of reduced activity for further power reduction – idle and power-down.

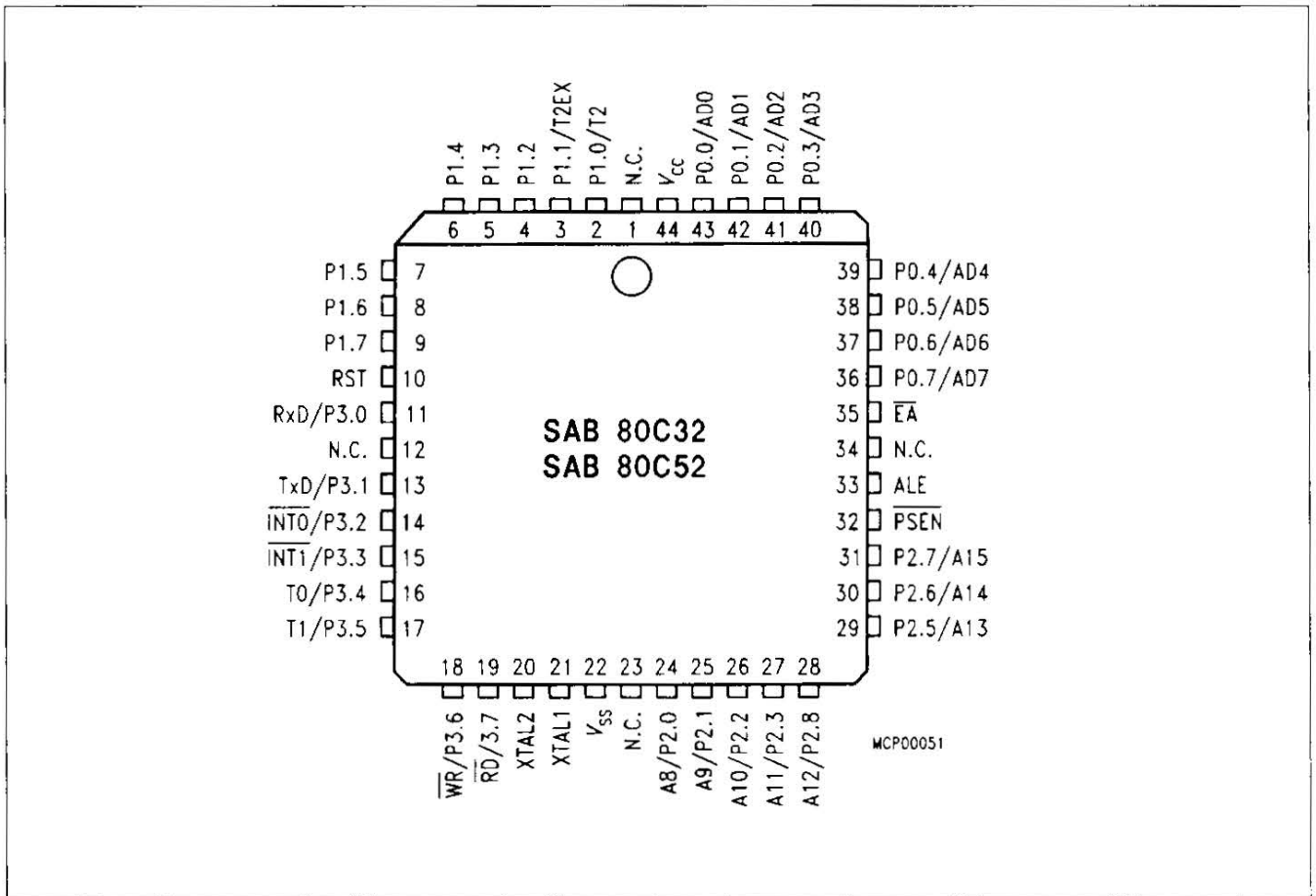
The SAB 80C52 contains a non-volatile 8 K × 8 read-only program memory, a volatile 256 K × 8 read/write data memory, 32 I/O lines, three 16-bit timer/counters, a six-source, two-priority-level interrupt structure, a serial I/O port, an on-chip oscillator, and clock circuits. The SAB 80C32 is identical, except that it lacks the program memory on the chip.

Ordering Information

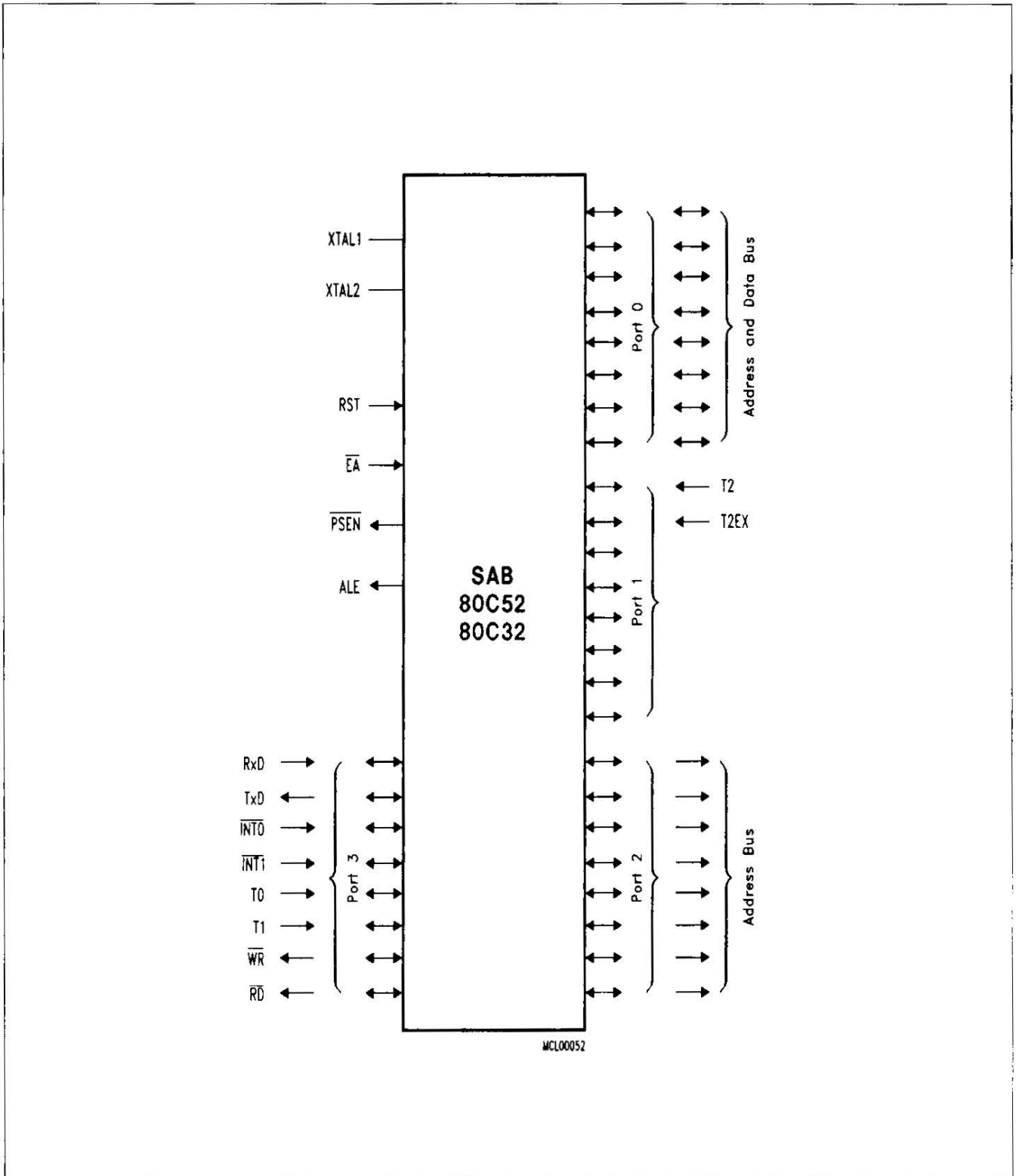
Type	Ordering code	Package	Description 8-bit CMOS microcontroller
SAB 80C52-N SAB 80C52-P	Q67120-C396 Q67120-C379	P-LCC-44 P-DIP-40	with factory mask-programmable ROM, 12 MHz
SAB 80C32-N SAB 80C32-P	Q67120-C395 Q67120-C378	P-LCC-44 P-DIP-40	for external memory, 12 MHz
SAB 80C52-P-T40/85	Q67120-C521	P-DIP-40	with factory mask-programmable ROM, 12 MHz, ext. temp. – 40 to 85 °C
SAB 80C32-P-T40/85	Q67120-C520	P-DIP-40	for external memory, 12 MHz, ext. temp. – 40 to 85 °C
SAB 80C52-16-N SAB 80C52-16-P	Q67120-C503 Q67120-C501	P-LCC-44 P-DIP-40	with factory mask-programmable ROM, 16 MHz
SAB 80C32-16-N SAB 80C32-16-P	Q67120-C502 Q67120-C500	P-LCC-44 P-DIP-40	for external memory, 16 MHz
SAB 80C52-16-P-T40/85	Q67120-C563	P-DIP-40	with factory mask-programmable ROM, 16 MHz, ext. temp. – 40 to 85 °C
SAB 80C32-16-P-T40/85	Q67120-C527	P-DIP-40	for external memory, 16 MHz ext. temp. -40 to 85 °C
SAB 80C52-20-N SAB 80C52-20-P	Q67120-C710 Q67120-C708	P-LCC-44 P-DIP-40	with factory mask-programmable ROM, 20 MHz
SAB 80C32-20-N SAB 80C32-20-P	Q67120-C711 Q67120-C709	P-LCC-44 P-DIP-40	for external memory, 20 MHz



Pin Configuration
(P-DIP-40)



Pin Configuration
(P-LCC-44)



Logic Symbol

Pin Definitions and Functions

Symbol	Pin Number		I/O *)	Function
	P-DIP-40	P-LCC-44		
P1.0-P1.7	1-8	2-9	I/O	<p>Port 1 is an 8-bit bidirectional I/O port with internal pullup resistors. Port 1 pins that have 1s written to them are pulled high by the internal pullup resistors, and in that state can be used as inputs. As inputs, port 1 pins being externally pulled low will source current (I_{IL}, on the DC characteristics) because of the internal pullup resistors. Port 1 also receives the low-order address bytes during program verification. Port 1 also contains the timer 2 pins as a secondary function. The output latch corresponding to a secondary function must be programmed to a one (1) for that function to operate. The secondary functions are assigned to the pins of port 1, as follows:</p> <ul style="list-style-type: none"> – T2 (P1.0): Input to counter 2. – T2 EX (P1.1): Capture/Reload trigger of timer 2.
RST	9	10	I	<p>A high level on this pin for two machine cycles while the oscillator is running resets the device. An internal diffused resistor to V_{SS} permits power-on reset using only an external capacitor to V_{CC}.</p>

* I = Input
 O = Output

Pin Definitions and Functions (cont'd)

Symbol	Pin Number		I/O *	Function
	P-DIP-40	P-LCC-44		
P3.0-P3.7	10-17	11, 13-19	I/O	<p>Port 3 is an 8-bit bidirectional I/O port with internal pullup resistors. Port 3 pins that have 1s written to them are pulled high by the internal pullup resistors, and in that state can be used as inputs. As inputs, port 3 pins being externally pulled low will source current (I_{IL}, on the DC characteristics) because of the internal pullup resistors. Port 3 also contains the interrupt, timer, serial port and \overline{RD} and \overline{WR} pins that are used by various options. The output latch corresponding to a secondary function must be programmed to a one (1) for that function to operate.</p> <p>The secondary functions are assigned to the pins of port 3, as follows:</p> <ul style="list-style-type: none"> - R x D/data (P3.0): Serial port's receiver data input (asynchronous) or data input/output (synchronous). - T x D/clock (P3.1): Serial port's transmitter data output (asynchronous) or clock output (synchronous). - $\overline{INT0}$ (P3.2): Interrupt 0 input or gate control input for counter 0. - $\overline{INT1}$ (P3.3): Interrupt 1 input or gate control input for counter 1. - T0 (P3.4): Input to counter 0. - T1 (P3.5): Input to counter 1. - \overline{WR} (P3.6): The write control signal latches the data byte from port 0 into the external data memory. - (P3.7): The read control signal enables external data memory to port 0.

* I = Input
O = Output

Pin Definitions and Functions (cont'd)

Symbol	Pin Number		I/O ^{*)}	Function
	P-DIP-40	P-LCC-44		
XTAL1 XTAL2	19 18	21 20	I/O	<p>XTAL 1 Input to the inverting oscillator amplifier and input to the internal clock generator circuits.</p> <p>XTAL 2 Output of the inverting oscillator amplifier. To drive the device from an external clock source, XTAL1 should be driven, while XTAL 2 is left unconnected. There are no requirements on the duty cycle of the external clock signal, since the input to the internal clocking circuitry is through a divide-by-two flip-flop. Minimum and maximum high and low times specified in the AC characteristics must be observed.</p>
P2.0-P2.7	21-28	24-31	I/O	<p>Port 2 is an 8-bit bidirectional I/O port with internal pullup resistors. Port 2 pins that have 1s written to them are pulled high by the internal pullup resistors, and in that state can be used as inputs. As inputs, port 2 pins being externally pulled low will source current (I_{IL}, on the DC characteristics) because of the internal pullup resist.</p> <p>Port 2 emits the high-order address byte during fetches from external program memory and during accesses to external data memory that use 16-bit addresses (MOVX@DPTR). In this application it uses strong internal pullup resistors when issuing 1s. During accesses to external data memory that use 8-bit addresses (MOVX@Ri), port 2 issues the contents of the P2 special function register.</p>

* I = Input
O = Output

Pin Definitions and Functions (cont'd)

Symbol	Pin Number		I/O *)	Function
	P-DIP-40	P-LCC-44		
$\overline{\text{PSEN}}$	29	32	O	<p>Program Store Enable</p> <p>This output issues a control signal that enables the external program memory to access the bus during external fetch operations. It is activated every six oscillator periods, except during external data memory accesses. Remains high during internal program execution.</p>
ALE	30	33	O	<p>Address Latch Enable</p> <p>Provides signal used for latching the address into external memory during normal operation. It is activated every six oscillator periods except during an external data memory access.</p>
$\overline{\text{EA}}$	31	35	I	<p>External Access</p> <p>When held at a high level, the SAB 80C52 executes instructions from the internal ROM when the PC is less than 8192. When held at a low level, the SAB 80C52 fetches all instructions from the external program memory. For the SAB 80C32 this pin must be tied low.</p>

* I = Input
 O = Output

Pin Definitions and Functions (cont'd)

Symbol	Pin Number		I/O *)	Function
	P-DIP-40	P-LCC-44		
				<p>Port 0 is an 8-bit open drain bidirectional I/O port. Port 0 pins that have 1s written to them float, and in that state can be used as high-impedance inputs. Port 0 is also the multiplexed low-order address and data bus during accesses to external program and data memory. In this application it uses strong internal pullup resistors when issuing 1s. Port 0 also outputs the code bytes during program verification in the SAB 80C52. External pullup resistors are required during program verification.</p>
V _{cc}	40	44		Supply voltage during normal, idle, and power-down operations.
V _{ss}	20	22		Circuit ground potential.
NC	—	1, 12, 23, 24	—	No connection.

* I = Input
 O = Output

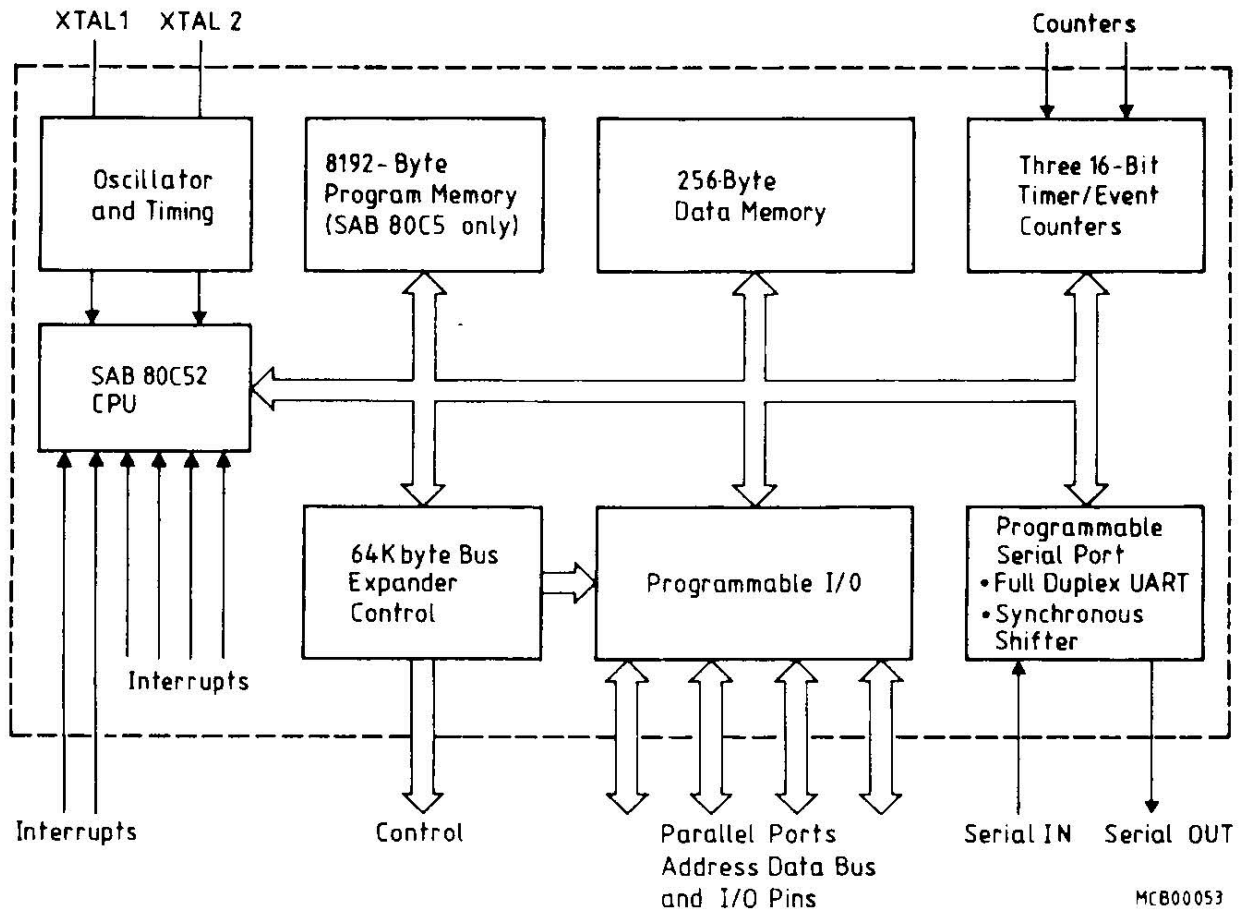


Figure 1
Block Diagram

Functional Description

The SAB 80C52/80C32 is functionally compatible with the SAB 8052A/8032A products that are designed in Siemens MYMOS technology. Furthermore, the SAB 80C52/80C32 is backwardly compatible with the SAB 80C51/80C31 devices.

In addition, instead of the RAM backup power supply of the SAB 8052A/8032A, the SAB 80C52/ 80C32 offers two additional power control modes, the idle mode and the power-down mode. The control bits for the reduced power modes are in the special function register PCON.

Idle mode

In the idle mode, the CPU puts itself to sleep while all the on-chip peripherals stay active. The instruction that invokes the idle mode is the last instruction executed in the normal operating mode before the idle mode is activated. The contents of the CPU, the on-chip RAM, and all the special function registers remain intact during this mode. The idle mode can be terminated either by any enabled interrupt, at which time the process is picked up at the interrupt service routine and continued, or by a hardware reset which starts the processor in the same way as a power-on reset.

Power-down mode

In the power-down mode the oscillator is stopped, and the instruction that invoke power-down is the last instruction executed. Only the contents of the on-chip RAM is preserved. A hardware reset is the only way to terminate power-down.

During power-down and idle mode the external pins will have the following status (see table 1):

Table 1
Status of the External Pins during Idle and Power-Down Modes

Mode	Program Memory	ALE	PSEN	Port 0	Port 1	Port 2	Port 3
Idle	Internal	1	1	Data	Data/ Alternate Outputs	Data	Data/ Alternate Outputs
Idle	External	1	1	Float	Data/ Alternate Outputs	Address	Data/ Alternate Outputs
Power-Down	Internal	0	0	Data	Data/ Last Out- put of Alternate Function	Data	Data/ Last Out- put of Alternate Function
Power-Down	External	0	0	Float	Data/ Last Out- put of Alternate Function	Data	Data/ Last Out- put of Alternate Function

Instruction Set

The SAB 80C52/80C32 has the same instruction set as the industry standard 8051 microcontroller.

A pocket guide is available which contains the complete instruction set in functional and hexadecimal order. Furtheron it provides helpful information about Special Function

Register, Interrupt Vectors and Assembler Directives.

Literature Information

Title	Ordering No.
Microcontroller Family SAB 8051 Pocket Guide	B158-B6229-X-X-7600

Absolute Maximum Ratings

Ambient temperature under bias.....	0 to 70 °C (SAB 80C52/80C32) – 40 to 85 °C (SAB 80C52/80C32-T40/85) – 40 to 110 °C (SAB 80C52/80C32-T40/110)
Storage temperature	– 65 to 150 °C
Voltage on any pin with respect to ground (V_{SS}).....	– 0.5 to V_{CC} 0.5 V
Voltage on V_{CC} to V_{SS}	– 0.5 to 6.5 V
Power dissipation.....	1 W

Note Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

DC Characteristics

$V_{CC} = 5 V \pm 10\%$; $V_{SS} = 0 V$; $T_A = 0$ to 70 °C (SAB 80C52/80C32)
 $T_A = -40$ to 85 °C (SAB 80C52/80C32-T40/85)
 $T_A = -40$ to 110 °C (SAB 80C52/80C32-T40/110)

Parameter	Symbol	Limit Values		Unit	Test condition
		min.	max.		
Input low voltage (except \overline{EA}) for SAB 80C52/80C32, 80C52/80C32-T40/85 for SAB 80C52/80C32, T40/110	V_{IL}	– 0.5 – 0.5	$0.2 V_{CC}$ – 0.1 $0.2 V_{CC}$ – 0.3	V	–
Input low voltage (\overline{EA})	V_{IL1}	– 0.5	$0.2 V_{CC}$ – 0.3	V	–
Input high voltage (except XTAL1, RST)	V_{IH}	$0.2 V_{CC}$ + 0.9	$0.2 V_{CC}$ + 0.5	V	–
Input high voltage (XTAL1, RST)	V_{IH1}	$0.7 V_{CC}$	$V_{CC} + 0.5$	V	–
Output low voltage (ports 1, 2, 3)	V_{OL}	–	0.45	V	$I_{OL} = 1.6 \text{ mA}^1$
Output low voltage (port 0, ALE, \overline{PSEN})	V_{OL1}	–	0.45	V	$I_{OL} = 3.2 \text{ mA}^1$
Output high voltage (ports 1, 2, 3)	V_{OH}	$2.4 V_{CC}$ 0.9	–	V	$I_{OH} = -80 \mu\text{A}$ $I_{OH} = -10 \mu\text{A}$

Notes see page 367

DC Characteristics (cont'd)

Parameter	Symbol	Limit Values		Unit	Test condition
		min.	max.		
Output high voltage (port 0 in external bus mode, ALE, PSEN)	V_{OH1}	$2.4 V_{CC}$	–	V	$I_{OL} = -800 \mu A$ $I_{OL} = -80 \mu A^{2)}$
		0.9	–	V	
Logical 0 input current (ports 1, 2, 3)	I_{IL}	–	– 50	V	$V_{IN} = 0.45 V$
Logical 1-to-0 transition current (ports 1, 2, 3)	I_{TL}	–	– 650	V V	$V_{IN} = 2 V$
Input leakage current (port 0, EA)	I_{LI}	–	± 10	μA	$0.45 < V_{IN} < V_{CC}$
Reset pulldown resistor	R_{RST}	40	150	k Ω	–
Pin capacitance	C_{IO}	–	10		$f \leq 1 MHz,$ $T_A = 25 ^\circ C$
Power supply current:					
Active mode, 12 MHz ⁶⁾	I_{CC}	–	20	mA	$V_{CC} = 5 V^{4)}$
Active mode, 16 MHz ⁶⁾	I_{CC}	–	26	mA	$V_{CC} = 5 V^{4)}$
Idle mode, 12 MHz ⁶⁾	I_{CC}	–	6.8	mA	$V_{CC} = 5 V^{5)}$
Idle mode, 16 MHz ⁶⁾	I_{CC}	–	8.4	mA	$V_{CC} = 5 V^{5)}$
Power Down Mode	I_{PD}	–	50	μA	$V_{CC} = 2...5.5 V^{3)}$

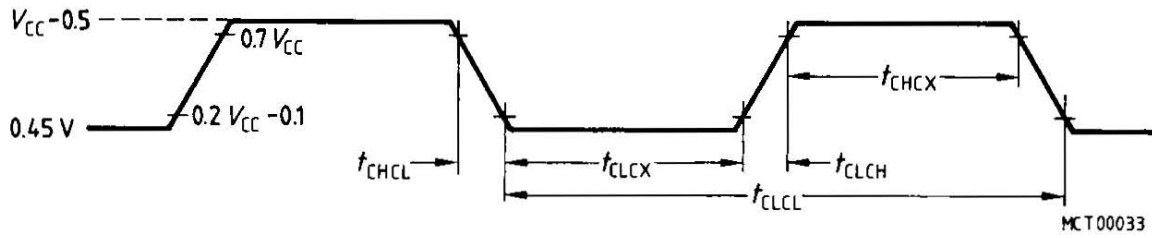
Notes see page 367

Notes for pages 365 and 366

- 1) Capacitive loading on ports 0 and 2 may cause spurious noise pulses to be superimposed on the V_{OL} of ALE and ports 1 and 3. The noise is due to external bus capacitance discharging into the port 0 and port 2 pins when these pins make 1-to-0 transitions during bus operation. In the worst case (capacitive loading > 100 pF), the noise pulse on ALE line may exceed 0.8 V. In such cases it may be desirable to qualify ALE with a Schmitt-trigger, or use an address latch with a Schmitt-trigger strobe input.
- 2) Capacitive loading on ports 0 and 2 may cause the V_{OH} on ALE and \overline{PSEN} to momentarily fall below the $0.9 V_{CC}$ specification when the address lines are stabilizing.
- 3) Power-down I_{CC} is measured with: $\overline{EA} = \text{Port 0} = V_{CC}$; XTAL1 = V_{SS} ; XTAL2 = N.C.;
- 4) I_{CC} (active mode) is measured with: XTAL1 driven with clock signal according to the figure below; XTAL2 = N.C.; $\overline{EA} = \text{Port 0} = V_{CC}$; RST = V_{CC} ; all other pins are disconnected. I_{CC} might be slightly higher if a crystal oscillator is used.
- 5) I_{CC} (idle mode) is measured with: XTAL1 driven with clock signal according to the figure below; XTAL2 = N.C.; $\overline{EA} = V_{SS}$; Port 0 = V_{CC} ; RST = V_{SS} ; all other pins are disconnected.
- 6) $I_{CC \text{ Max}}$ at other frequencies is given by:

active mode:	$I_{CC \text{ Max}} = 1.5 * f_{OSC} + 2.0$
idle mode:	$I_{CC \text{ Max}} = 0.4 * f_{OSC} + 2.0$

where f_{OSC} is the oscillator frequency in MHz. I_{CC} values are given in mA and measured at $V_{CC} = 5 \text{ V}$ (see also notes 5 and 6)



Clock Signal Waveform for I_{CC} Tests in Active and Idle Mode

AC Characteristics

$V_{CC} = 5 V \pm 10\%$; $V_{SS} = 0 V$;

$T_A = 0$ to $70^\circ C$; (SAB 80C52/80C32)

$T_A = -40$ to $85^\circ C$; (SAB 80C52/80C32 – T40/85)

$T_A = -40$ to $110^\circ C$; (SAB 80C52/80C32 – T40/110)

(C_L for port 0, ALE and PSEN outputs = 100 pF; C_L for all other outputs = 80 pF)

Parameter	Symbol	Limit values				Unit
		12 MHz clock		Variable clock $1/t_{CLCL} = 0.5$ MHz to 12 MHz		
		min	max.	min.	max.	

Program Memory Characteristics

ALE pulse width	t_{LHLL}	127	–	$2 t_{CLCL} - 40$	–	ns
Address setup to ALE	t_{AVLL}	43	–	$t_{CLCL} - 40$	–	ns
Address hold after ALE	t_{LLAX}	60	–	$t_{CLCL} - 23$	–	ns
Address to valid instruction in	t_{LLIV}	–	233	–	$4t_{CLCL} - 100$	ns
ALE to \overline{PSEN}	t_{LLPL}	58	–	$t_{CLCL} - 25$	–	ns
\overline{PSEN} pulse width	t_{PLPH}	215	–	$3 t_{CLCL} - 35$	–	ns
\overline{PSEN} to valid instruction	t_{PLIV}	–	150	–	$3t_{CLCL} - 100$	ns
Input instruction hold after \overline{PSEN}	t_{PXIX}	0	–	0	–	ns
Input instruction float after \overline{PSEN}	$t_{PXIZ}^*)$	–	63	–	$t_{CLCL} - 20$	ns
Address valid after \overline{PSEN}	$t_{PXAV}^*)$	75	–	$t_{CLCL} - 8$	–	ns
Address to valid instruction in	t_{AVIV}	–	302	0	$5t_{CLCL} - 115$	ns
Address float to \overline{PSEN}	t_{PLAZ}	–	0	–	0	ns

*) Interfacing the SAB 80C515A to devices with float times up to 45 ns is permissible.
This limited bus contention will not cause any damage to port 0 drivers.

AC Characteristics (cont'd)

Parameter	Symbol	Limit values				Unit
		12 MHz clock		Variable clock 1/t _{CLCL} = 0.5 MHz to 12 MHz		
		min	max.	min.	max.	

External Data Memory Characteristics

\overline{RD} pulse width	t _{RLRH}	400	–	6 t _{CLCL} – 100	–	ns
\overline{WR} pulse width	t _{WLWH}	400	–	6 t _{CLCL} – 100	–	ns
Address hold after ALE	t _{LLAX2}	132	–	2 t _{CLCL} – 35	–	ns
\overline{RD} to valid data in	t _{RLDV}	–	252	–	5 t _{CLCL} – 165	ns
Data hold after \overline{RD}	t _{RHDX}	0	–	0	–	ns
Data float after \overline{RD}	t _{RHDZ}	–	97	–	2 t _{CLCL} – 70	ns
ALE to valid data in	t _{LLDV}	–	517	–	8 t _{CLCL} – 150	ns
Address to valid data in	t _{AVDV}	–	585	–	9 t _{CLCL} – 165	ns
ALE to \overline{WR} or \overline{RD}	t _{LLWL}	200	300	3 t _{CLCL} – 50	3 t _{CLCL} + 50	ns
\overline{WR} or \overline{RD} high to ALE high	t _{WHLH}	43	123	t _{CLCL} – 40	t _{CLCL} + 40	ns
Address valid to \overline{WR} or \overline{RD}	t _{AVWL}	203	–	4 t _{CLCL} – 130	–	ns
Data valid to \overline{WR} transition	t _{QVWX}	33	–	t _{CLCL} – 50	–	ns
Data setup before \overline{WR}	t _{QVWX}	433	–	7 t _{CLCL} – 150	–	ns
Data hold after \overline{WR}	t _{WHQX}	33	–	t _{CLCL} – 50	–	ns
Address float after \overline{RD}	t _{RLAZ}	–	0	–	0	ns

AC Characteristics (cont'd)

Parameter	Symbol	Limit values		Unit
		Variable clock Frequ. = 0.5 MHz to 12 MHz		
		min	max.	

External Clock Drive XTAL1

Oscillator period	t_{CLCL}	83.3	2000	ns
High time	t_{CHCX}	20	$t_{CLCL} - t_{CHCX}$	ns
Low time	t_{CLCX}	20	$t_{CLCL} - t_{CHCX}$	ns
Rise time	t_{CLCH}	-	20	ns
Fall time	t_{CHCL}	-	20	ns

AC Characteristics (cont'd)

$V_{CC} = 5\text{ V} \pm 10\%$; $V_{SS} = 0\text{ V}$;

$T_A = 0\text{ to }70\text{ }^\circ\text{C}$; (SAB 80C52-16/80C32-16)

$T_A = -40\text{ to }85\text{ }^\circ\text{C}$; (SAB 80C52-16/80C32-16 – T40/85)

$T_A = -40\text{ to }110\text{ }^\circ\text{C}$; (SAB 80C52-16/80C32-16 – T40/110)

(C_L for port 0, ALE and $\overline{\text{PSEN}}$ outputs = 100 pF; C_L for all other outputs = 80 pF)

Parameter	Symbol	Limit values				Unit
		16 MHz clock		Variable clock $1/t_{CLCL} = 0.5\text{ MHz to }16\text{ MHz}$		
		min	max.	min.	max.	

Program Memory Characteristics

ALE pulse width	t_{LHLL}	85	–	$2 t_{CLCL} - 40$	–	ns
Address setup to ALE	t_{AVLL}	23	–	$t_{CLCL} - 40$	–	ns
Address hold after ALE	t_{LLAX}	40	–	$t_{CLCL} - 23$	–	ns
Address to valid instruction in	t_{LLIV}	–	233	–	$4t_{CLCL} - 100$	ns
ALE to $\overline{\text{PSEN}}$	t_{LLPL}	38	–	$t_{CLCL} - 25$	–	ns
$\overline{\text{PSEN}}$ pulse width	t_{PLPH}	153	–	$3 t_{CLCL} - 35$	–	ns
$\overline{\text{PSEN}}$ to valid instruction in	t_{PLIV}	–	150	–	$3t_{CLCL} - 100$	ns
Input instruction hold after $\overline{\text{PSEN}}$	t_{PXIX}	0	–	0	–	ns
Input instruction float after $\overline{\text{PSEN}}$	t_{PXIZ}	–	63	–	$t_{CLCL} - 15$	ns
Address valid after $\overline{\text{PSEN}}$	$t_{PXAV}^*)$	60	–	$t_{CLCL} - 3$	–	ns
Address to valid instruction in	$t_{AVIV}^*)$	–	302	0	$5t_{CLCL} - 90$	ns
Address float to $\overline{\text{PSEN}}$	t_{PLAZ}	–	0	–	0	ns

*) Interfacing the SAB 80C52-16/80C32-16 to devices with float times up to 45 ns permissible. This limited bus contention will not cause any damage to port 0 drivers

AC Characteristics (cont'd)

Parameter	Symbol	Limit values				Unit
		16 MHz clock		Variable clock 1/t _{CLCL} = 0.5 MHz to 16 MHz		
		min	max.	min.	max.	

External Data Memory Characteristics

\overline{RD} pulse width	t _{RLRH}	275	–	6 t _{CLCL} – 100	–	ns
\overline{WR} pulse width	t _{WLWH}	275	–	6 t _{CLCL} – 100	–	ns
Address hold after ALE	t _{LLAX2}	90	–	2 t _{CLCL} – 35	–	ns
\overline{RD} to valid data in	t _{RLDV}	–	148	–	5 t _{CLCL} – 165	ns
Data hold after \overline{RD}	t _{RHDX}	0	–	0	–	ns
Data float after \overline{RD}	t _{RHDZ}	–	55	–	2 t _{CLCL} – 70	ns
ALE to valid data in	t _{LLDV}	–	350	–	8 t _{CLCL} – 150	ns
Address to valid data in	t _{AVDV}	–	398	–	9 t _{CLCL} – 165	ns
ALE to \overline{WR} or \overline{RD}	t _{LLWL}	138	238	3 t _{CLCL} – 50	3 t _{CLCL} + 50	ns
Address valid to \overline{WR} or \overline{RD}	t _{AVWL}	120	–	4 t _{CLCL} – 130	–	ns
\overline{WR} or \overline{RD} high to ALE high	t _{WHLH}	23	103	t _{CLCL} – 40	t _{CLCL} + 40	ns
Data valid to \overline{WR} transition	t _{QVWX}	13	–	t _{CLCL} – 50	–	ns
Data setup before \overline{WR}	t _{QVWX}	288	–	7 t _{CLCL} – 150	–	ns
Data hold after \overline{WR}	t _{WHQX}	13	–	t _{CLCL} – 50	–	ns
Address float after \overline{RD}	t _{RLAZ}	–	0	–	0	ns

AC Characteristics (cont'd)

Parameter	Symbol	Limit values		Unit
		Variable clock Frequ. = 0.5 MHz to 16 MHz		
		min	max.	

External Clock Drive XTAL1

Oscillator period	t_{CLCL}	62.5	2000	ns
High time	t_{CHCX}	15	$t_{CLCL} - t_{CHCX}$	ns
Low time	t_{CLCX}	15	$t_{CLCL} - t_{CHCX}$	ns
Rise time	t_{CLCH}	-	15	ns
Fall time	t_{CHCL}	-	15	ns

AC Characteristics (cont'd)

$V_{CC} = 5 V \pm 10\%$; $V_{SS} = 0 V$;

$T_A = 0$ to $70^\circ C$; (SAB 80C52-20/80C32-20)

$T_A = -40$ to $85^\circ C$; (SAB 80C52-20/80C32-20 – T40/85)

$T_A = -40$ to $110^\circ C$; (SAB 80C52-20/80C32-20 – T40/110)

(C_L for port 0, ALE and \overline{PSEN} outputs = 100 pF; C_L for all other outputs = 80 pF)

Parameter	Symbol	Limit values				Unit
		20 MHz clock		Variable clock $1/t_{CLCL} = 0.5 \text{ MHz to } 20 \text{ MHz}$		
		min	max.	min.	max.	

Program Memory Characteristics

ALE pulse width	t_{LHLL}	60	–	$2 t_{CLCL} - 40$	–	ns
Address setup to ALE	t_{AVLL}	20	–	$t_{CLCL} - 30$	–	ns
Address hold after ALE	t_{LLAX}	20	–	$t_{CLCL} - 30$	–	ns
Address to valid instruction in	t_{LLIV}	–	100	–	$4t_{CLCL} - 100$	ns
ALE to \overline{PSEN}	t_{LLPL}	25	–	$t_{CLCL} - 25$	–	ns
\overline{PSEN} pulse width	t_{PLPH}	115	–	$3 t_{CLCL} - 35$	–	ns
\overline{PSEN} to valid instruction in	t_{PLIV}	–	75	–	$3t_{CLCL} - 75$	ns
Input instruction hold after \overline{PSEN}	t_{PXIX}	0	–	0	–	ns
Input instruction float after \overline{PSEN}	t_{PXIZ}	–	40	–	$t_{CLCL} - 10$	ns
Address valid after \overline{PSEN}	$t_{PXAV}^*)$	47	–	$t_{CLCL} - 3$	–	ns
Address to valid instruction in	$t_{AVIV}^*)$	–	190	0	$5t_{CLCL} - 60$	ns
Address float to \overline{PSEN}	t_{PLAZ}	–	10	–	0	ns

*) Interfacing the SAB 80C52-20/80C32-20 to devices with float times up to 45 ns permissible.
This limited bus contention will not cause any damage to port 0 drivers

AC Characteristics (cont'd)

Parameter	Symbol	Limit values				Unit
		20 MHz clock		Variable clock 1/t _{CLCL} = 0.5 MHz to 20 MHz		
		min	max.	min.	max.	

External Data Memory Characteristics

\overline{RD} pulse width	t _{RLRH}	200	–	6 t _{CLCL} – 100	–	ns
\overline{WR} pulse width	t _{WLWH}	200	–	6 t _{CLCL} – 100	–	ns
Address hold after ALE	t _{LLAX2}	65	–	2 t _{CLCL} – 35	–	ns
\overline{RD} to valid data in	t _{RLDV}	–	85	–	5 t _{CLCL} – 165	ns
Data hold after \overline{RD}	t _{RHDX}	0	–	0	–	ns
Data float after \overline{RD}	t _{RHDZ}	–	40	–	2 t _{CLCL} – 60	ns
ALE to valid data in	t _{LLDV}	–	250	–	8 t _{CLCL} – 150	ns
Address to valid data in	t _{AVDV}	–	285	–	9 t _{CLCL} – 165	ns
ALE to \overline{WR} or \overline{RD}	t _{LLWL}	100	200	3 t _{CLCL} – 50	3 t _{CLCL} + 50	ns
Address valid to \overline{WR} or \overline{RD}	t _{AVWL}	70	–	4 t _{CLCL} – 130	–	ns
\overline{WR} or \overline{RD} high to ALE high	t _{WHLH}	20	80	t _{CLCL} – 30	t _{CLCL} + 30	ns
Data valid to \overline{WR} transition	t _{QVWX}	5	–	t _{CLCL} – 45	–	ns
Data setup before \overline{WR}	t _{QVWX}	200	–	7 t _{CLCL} – 150	–	ns
Data hold after \overline{WR}	t _{WHQX}	10	–	t _{CLCL} – 40	–	ns
Address float after \overline{RD}	t _{RLAZ}	–	0	–	0	ns

AC Characteristics (cont'd)

Parameter	Symbol	Limit values		Unit
		Variable clock Frequ. = 0.5 MHz to 20 MHz		
		min	max.	

External Clock Drive XTAL1

Oscillator period	t_{CLCL}	50	2000	ns
High time	t_{CHCX}	12	$t_{CLCL} - t_{CHCX}$	ns
Low time	t_{CLCX}	12	$t_{CLCL} - t_{CHCX}$	ns
Rise time	t_{CLCH}	-	12	ns
Fall time	t_{CHCL}	-	12	ns

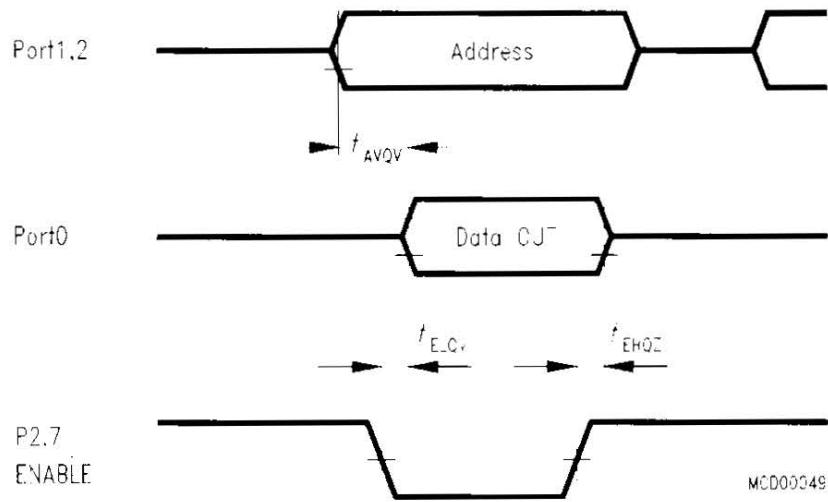
ROM Verification Characteristics

$T_A = 25^\circ\text{C} \pm 5^\circ\text{C}$; $V_{CC} = 5\text{ V} \pm 10\%$; $V_{SS} = 0\text{ V}$

Parameter	Symbol	Limit values		Unit
		min	max.	

ROM Verification

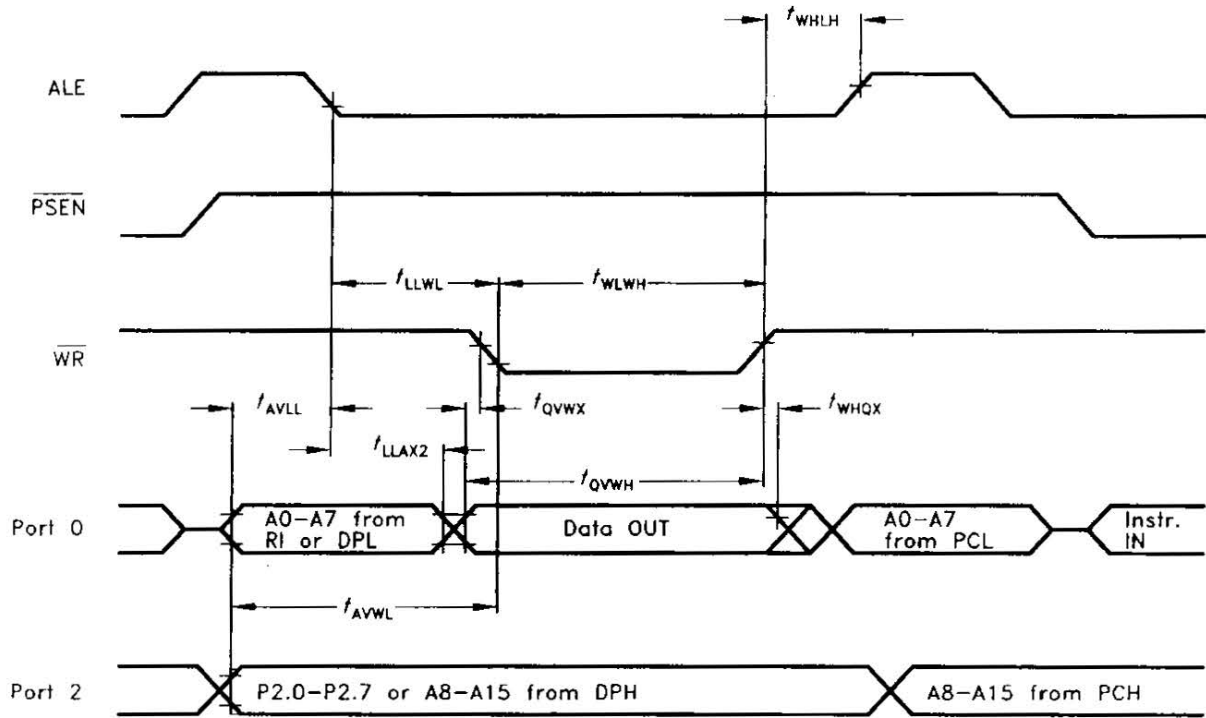
Address to valid data	t_{AVQV}	-	48 t_{CLCL}	ns
$\overline{\text{ENABLE}}$ to valid data	t_{ELQV}	-	48 t_{CLCL}	ns
Data float after $\overline{\text{ENABLE}}$	t_{EHOZ}	0	48 t_{CLCL}	ns
Oscillator frequency	$1/t_{CLCL}$	4	6	MHz



Address: P1.0–P1.7 = A0–A7
 P2.0–P2.4 = A8–A12
 Data: Port 0 = D0–D7

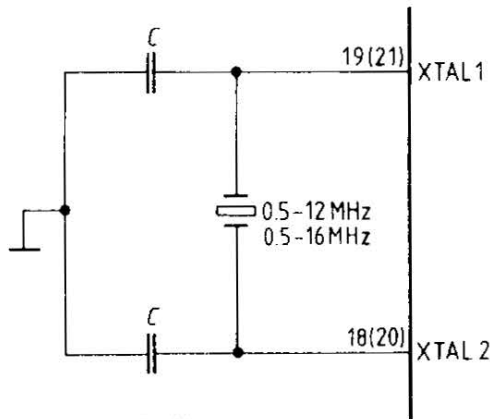
Inputs: P2.5–P2.6, $\overline{\text{PSEN}}$ = V_{SS}
 ALE, $\overline{\text{EA}}$ = V_{IH}
 RST = V_{IH1}

ROM Verification



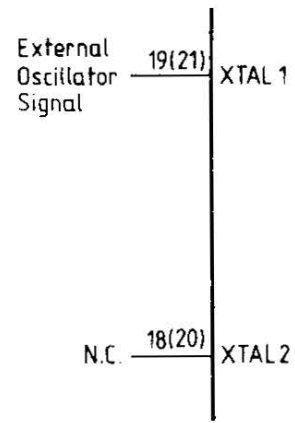
MCT00910

Data Memory Write Cycle



$C = 30 \text{ pF} \pm 10 \text{ pF}$

Crystal Oscillator Mode

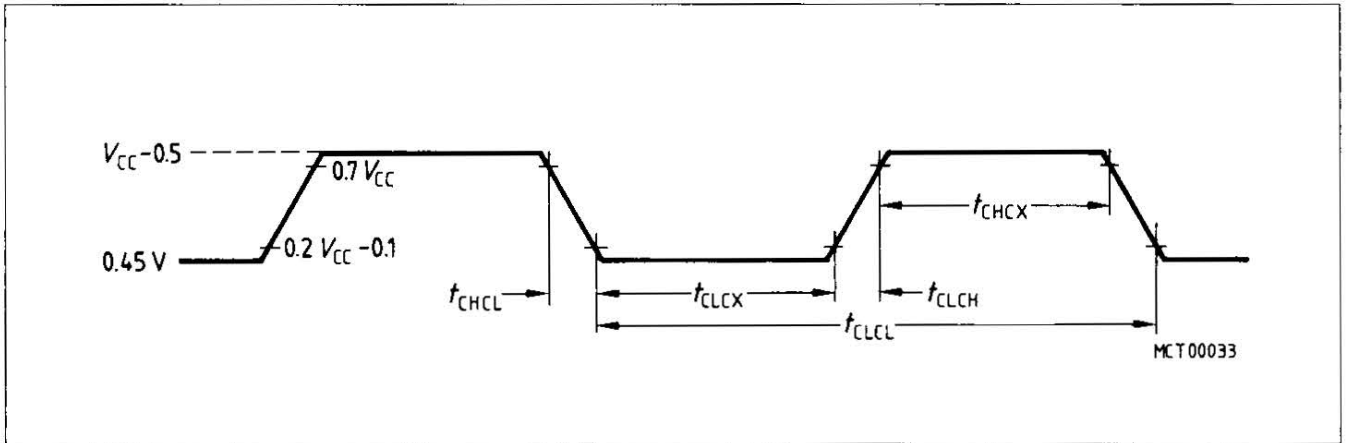


MCS00911

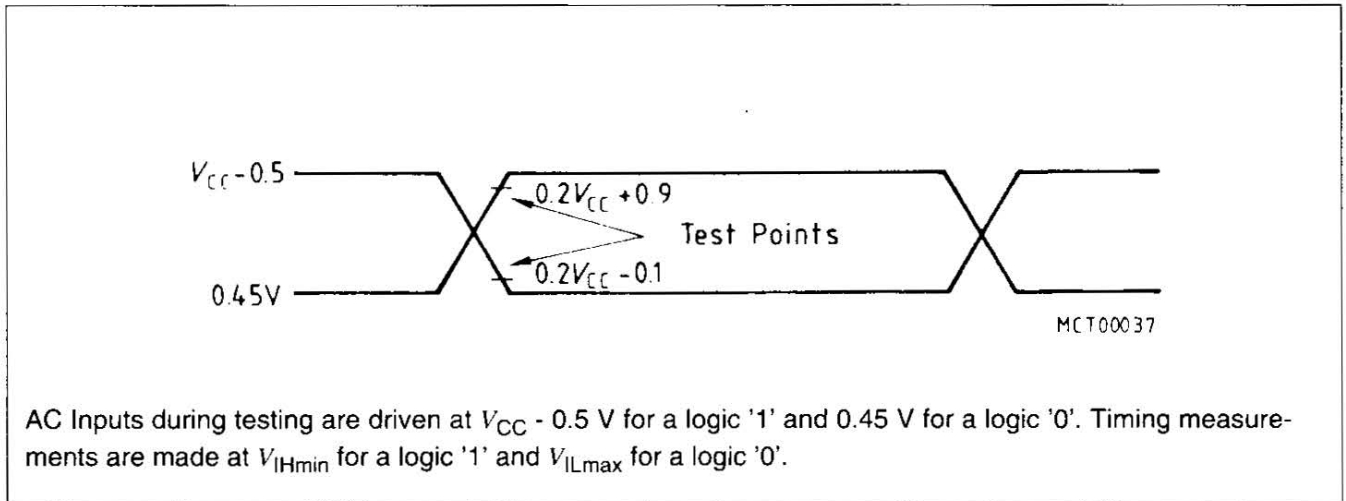
Driving from External Source

Pin numbers (. . .) are for PL-CC-44 package

Recommended Oscillator Circuits

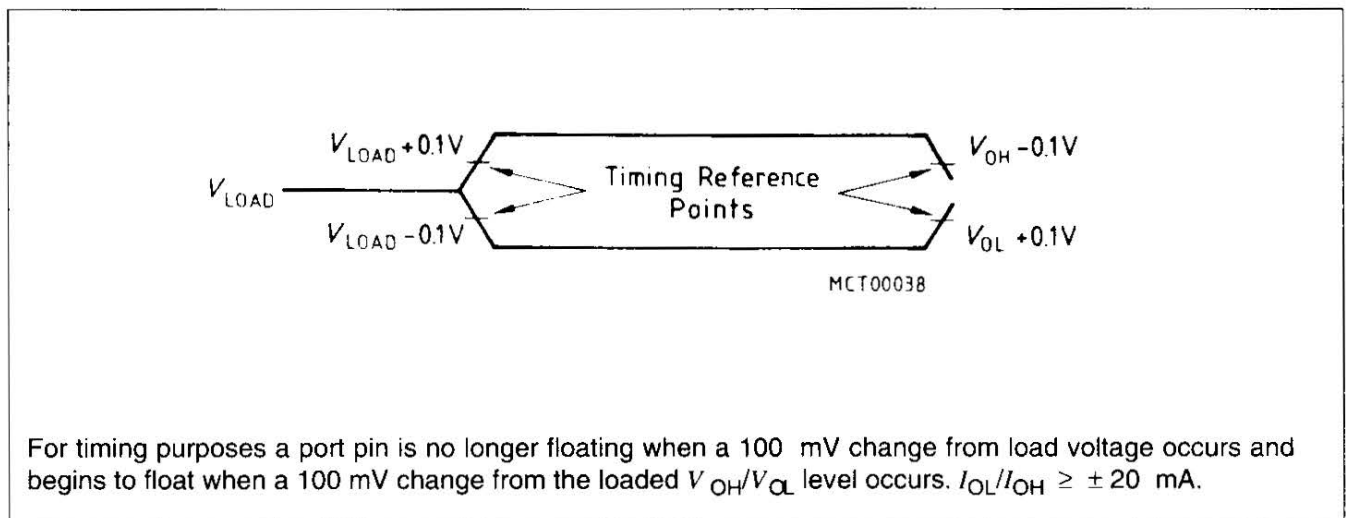


External Clock Cycle



AC Inputs during testing are driven at $V_{CC} - 0.5\text{ V}$ for a logic '1' and 0.45 V for a logic '0'. Timing measurements are made at V_{IHmin} for a logic '1' and V_{ILmax} for a logic '0'.

AC Testing: Input, Output Waveforms



For timing purposes a port pin is no longer floating when a 100 mV change from load voltage occurs and begins to float when a 100 mV change from the loaded V_{OH}/V_{OL} level occurs. $I_{OL}/I_{OH} \geq \pm 20\text{ mA}$.

AC Testing: Float Waveforms